ANALOG DEVICES

18-Bit, 250 kSPS PulSAR Differential ADC in MSOP

Enhanced Product

AD7691-EP

FEATURES

18-bit resolution with no missing codes
Throughput: 250 kSPS
INL
  ±0.75 LSB typical
  ±1.5 LSB minimum/maximum at −40°C to +85°C
  −2.7 LSB/+2 LSB minimum/maximum at −55°C to +105°C
Dynamic range: 102 dB typical
Oversampled dynamic range: 125 dB at 1 kSPS
Noise-free code resolution: 20 bits at 1 kSPS
Effective resolution: 22.7 bits at 1 kSPS
SINAD: 101 dB typical at f_{IN} = 1 kHz, V_{REF} = 5 V
THD: −125 dB typical at f_{IN} = 1 kHz, V_{REF} = 5 V
True differential analog input range: ±V_{REF}
0 V to V_{REF} with V_{REF} up to VDD on both inputs
No pipeline delay
Single-supply 2.3 V to 5 V operation with 1.8 V/2.5 V/3 V/5 V
  logic interface
Serial interface SPI-/QSPI™-/MICROWIRE™-/DSP-compatible
Ability to daisy-chain multiple ADCs
Optional busy indicator feature
Power dissipation
  1.35 mW at VDD = 2.5 V, 100 kSPS throughput
  4.24 mW at VDD = 5 V, 100 kSPS throughput
  1.4 µW at VDD = 2.5 V, 100 SPS throughput
Standby current: 1 nA
10-lead MSOP
Pin-for-pin compatible with the18-bit AD7690 and 16-bit
  AD7693, AD7688, and AD7687

ENHANCED PRODUCT FEATURES

Supports defense and aerospace applications (AQEC standard)
Military temperature range: −55°C to +105°C
Controlled manufacturing baseline
One assembly/test site
One fabrication site
Enhanced product change notification
Qualification data available on request

APPLICATIONS

Battery-powered equipment
Data acquisitions
Seismic data acquisition systems
Instrumentation
Medical instruments

APPLICATION DIAGRAM
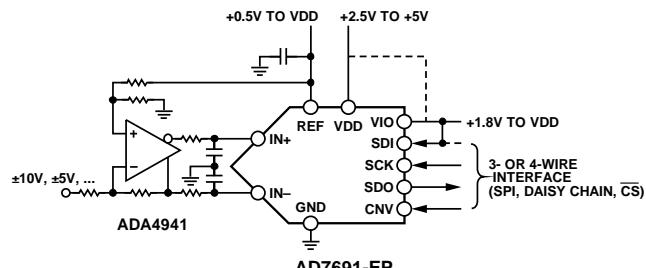
Figure 1.

GENERAL DESCRIPTION

The AD7691-EP is an 18-bit, charge redistribution, successive approximation, analog-to-digital converter (ADC) that operates from a single power supply, VDD, between 2.3 V and 5 V. It contains a low power, high speed, 18-bit sampling ADC with no missing codes, an internal conversion clock, and a versatile serial interface port. On the CNV rising edge, it samples the voltage difference between the IN+ and IN− pins. The voltages on these pins swing in opposite phases between 0 V and REF.

The reference voltage, REF, is applied externally and can be set up to the supply voltage.

The power of the AD7691-EP scales linearly with throughput.

The SPI-compatible serial interface also features the ability, using the SDI input, to daisy-chain several ADCs on a single 3-wire bus and provides an optional busy indicator. It is compatible with 1.8 V, 2.5 V, 3 V, or 5 V logic, using the separate VIO supply.

The AD7691-EP is housed in a 10-lead MSOP with operation specified from −55°C to +105°C. Additional application and technical information can be found in the AD7691 data sheet.
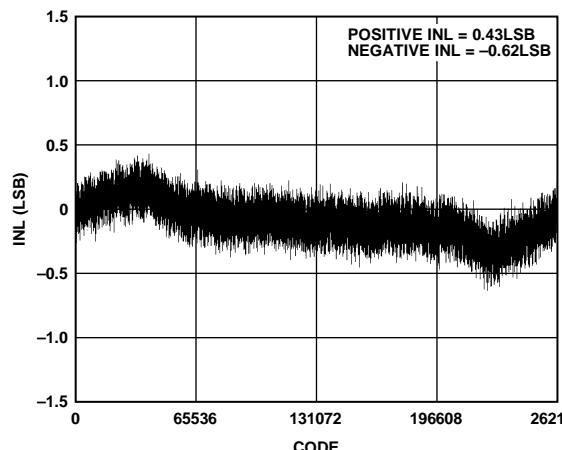

Figure 2. Integral Nonlinearity vs. Code, 5 V

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REVISION HISTORY

8/15—Rev. 0 to Rev. A
Added Enhanced Product Features Section 1

9/14—Revision 0: Initial Version

SPECIFICATIONS

VDD = 2.3 V to 5.25 V, VIO = 2.3 V to VDD, V_{REF} = VDD, all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 1.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
RESOLUTION		18			Bits
ANALOG INPUT					
Voltage Range, V_{IN}	IN+ − (IN−)	$-V_{REF}$		$+V_{REF}$	V
Absolute Input Voltage Range	IN+, IN−	−0.1		V_{REF} + 0.1	V
Common-Mode Input Range	IN+, IN−	$V_{REF}/2$ − 0.1	$V_{REF}/2$	$V_{REF}/2$ + 0.1	V
Analog Input Common-Mode Rejection Ratio (CMRR)	f_{IN} = 250 kHz		65		dB
Leakage Current at 25°C	Acquisition phase		1		nA
Input Impedance [1]					
THROUGHPUT					
Conversion Rate	VDD = 4.5 V to 5.25 V	0		250	kSPS
	VDD = 2.3 V to 4.5 V	0		180	kSPS
Transient Response	Full-scale step			1.8	µs
ACCURACY					
No Missing Codes		18			Bits
Integral Linearity Error	−55°C to +105°C	−2.7	±0.75	+2	LSB[2]
	−40°C to +85°C	−1.5	±0.75	+1.5	LSB[2]
Differential Linearity Error		−1	±0.5	+1.25	LSB[2]
Transition Noise	REF = VDD = 5 V		0.75		LSB[2]
Gain Error [3]	VDD = 4.5 V to 5.25 V	−40	±2	+40	LSB[2]
	VDD = 2.3 V to 4.5 V	−80	±2	+80	LSB[2]
Gain Error Temperature Drift			±0.3		ppm/°C
Zero Error [3]	VDD = 4.5 V to 5.25 V	−0.8	±0.1	+0.8	mV
	VDD = 2.3 V to 4.5 V	−3.5	±0.7	+3.5	mV
Zero Temperature Drift			±0.3		ppm/°C
Power Supply Sensitivity	VDD = 5 V ± 5%		±0.25		LSB[2]
AC ACCURACY [4]					
Dynamic Range	V_{REF} = 5 V	101	102		dB
Oversampled Dynamic Range [5]	f_{IN} = 1 kSPS		125		dB
Signal-to-Noise					
f_{IN} = 1 kHz, V_{REF} = 5 V	−55°C to +105°C	98.5	101		dB
	−40°C to +85°C	100	101.5		dB
f_{IN} = 1 kHz, V_{REF} = 2.5 V	−55°C to +105°C	94	96		dB
	−40°C to +85°C	95	96.5		dB
Spurious-Free Dynamic Range	f_{IN} = 1 kHz, V_{REF} = 5 V		−125		dB
Total Harmonic Distortion	f_{IN} = 1 kHz, V_{REF} = 5 V		−118		dB
Signal-to-Noise-and-Distortion Ratio (SINAD)					
f_{IN} = 1 kHz, V_{REF} = 5 V	−55°C to +105°C	98.5	101		dB
	−40°C to +85°C	100	101.5		dB
f_{IN} = 1 kHz, V_{REF} = 2.5 V	−55°C to +105°C	94	96		dB
	−40°C to +85°C	95	96.5		dB
Intermodulation Distortion [6]			115		dB

[1] See the Analog Inputs section of the AD7691 data sheet.
[2] LSB means least significant bit. With the ±5 V input range, one LSB is 38.15 µV.
[3] See the Terminology section of the AD7691 data sheet. These specifications include full temperature range variation but not the error contribution from the external reference.
[4] All ac accuracy specifications in dB are referred to a full-scale input FSR. Tested with an input signal at 0.5 dB below full scale, unless otherwise specified.
[5] Dynamic range obtained by oversampling the ADC running at a throughput f_S of 250 kSPS, followed by postdigital filtering with an output word rate f_O.
[6] f_{IN1} = 21.4 kHz and f_{IN2} = 18.9 kHz, with each tone at −7 dB below full scale.

VDD = 2.3 V to 5.25 V, VIO = 2.3 V to VDD, V_{REF} = VDD, all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 2.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
REFERENCE					
Voltage Range		0.5		VDD + 0.3	V
Load Current	250 kSPS, REF = 5 V		60		μA
SAMPLING DYNAMICS					
−3 dB Input Bandwidth			2		MHz
Aperture Delay	VDD = 5 V		2.5		ns
DIGITAL INPUTS					
Logic Levels					
V_{IL}		−0.3		$+0.3 \times VIO$	V
V_{IH}		$0.7 \times VIO$		VIO + 0.3	V
I_{IL}		−1		+1	μA
I_{IH}		−1		+1	μA
DIGITAL OUTPUTS					
Data Format	Serial 18-bit, twos complement				
Pipeline Delay[1]					
V_{OL}	I_{SINK} = +500 μA			0.4	V
V_{OH}	I_{SOURCE} = −500 μA	VIO − 0.3			V
POWER SUPPLIES					
VDD Range	Specified performance	2.3		5.25	V
VIO Range	Specified performance	2.3		VDD + 0.3	V
VIO Range	Functional operation	1.8		VDD + 0.3	V
Standby Current[2,3]	VDD and VIO = 5 V, T_A = 25°C		1	50	nA
Power Dissipation	VDD = 2.5 V, 100 SPS throughput		1.4		μW
	VDD = 2.5 V, 100 kSPS throughput		1.35		mW
	VDD = 2.5 V, 180 kSPS throughput		2.4		mW
	VDD = 5 V, 100 kSPS throughput		4.24	5	mW
	VDD = 5 V, 250 kSPS throughput		10.6	12.5	mW
Energy per Conversion			50		nJ/sample
TEMPERATURE RANGE[4]					
Specified Performance	T_{MIN} to T_{MAX}	−55		+105	°C

[1] Conversion results are available immediately after completed conversion.
[2] With all digital inputs forced to VIO or GND as required.
[3] During acquisition phase.
[4] Contact an Analog Devices, Inc., sales representative for the extended temperature range.

TIMING SPECIFICATIONS

VDD = 4.5 V to 5.25 V, VIO = 2.3 V to VDD, V_{REF} = VDD, all specifications T_{MIN} to T_{MAX}, unless otherwise noted. See Figure 3 and Figure 4 for load conditions.

Table 3.

Parameter	Symbol	Min	Typ	Max	Unit
Conversion Time: CNV Rising Edge to Data Available	t_{CONV}	0.5		2.2	μs
Acquisition Time	t_{ACQ}	1.8			μs
Time Between Conversions	t_{CYC}	4			μs
CNV Pulse Width ($\overline{CS}$ Mode)	t_{CNVH}	10			ns
SCK Period ($\overline{CS}$ Mode)	t_{SCK}	15			ns
SCK Period (Chain Mode)	t_{SCK}				
VIO Above 4.5 V		17			ns
VIO Above 3 V		18			ns
VIO Above 2.7 V		19			ns
VIO Above 2.3 V		20			ns
SCK Low Time	t_{SCKL}	7			ns
SCK High Time	t_{SCKH}	7			ns
SCK Falling Edge to Data Remains Valid	t_{HSDO}	4			ns
SCK Falling Edge to Data Valid Delay	t_{DSDO}				
VIO Above 4.5 V				14	ns
VIO Above 3 V				15	ns
VIO Above 2.7 V				16	ns
VIO Above 2.3 V				17	ns
CNV or SDI Low to SDO D17 MSB Valid ($\overline{CS}$ Mode)	t_{EN}				
VIO Above 4.5 V				15	ns
VIO Above 2.7 V				18	ns
VIO Above 2.3 V				23	ns
CNV or SDI High or Last SCK Falling Edge to SDO High Impedance ($\overline{CS}$ Mode)	t_{DIS}			25	ns
SDI Valid Setup Time from CNV Rising Edge ($\overline{CS}$ Mode)	$t_{SSDICNV}$	15			ns
SDI Valid Hold Time from CNV Rising Edge ($\overline{CS}$ Mode)	$t_{HSDICNV}$	0			ns
SCK Valid Setup Time from CNV Rising Edge (Chain Mode)	$t_{SSCKCNV}$	5			ns
SCK Valid Hold Time from CNV Rising Edge (Chain Mode)	$t_{HSCKCNV}$	10			ns
SDI Valid Setup Time from SCK Falling Edge (Chain Mode)	$t_{SSDISCK}$	3			ns
SDI Valid Hold Time from SCK Falling Edge (Chain Mode)	$t_{HSDISCK}$	4			ns
SDI High to SDO High (Chain Mode with Busy Indicator)	$t_{DSDOSDI}$				
VIO Above 4.5 V				15	ns
VIO Above 2.3 V				26	ns

VDD = 2.3 V to 4.5 V, VIO = 2.3 V to VDD, V_{REF} = VDD, all specifications T_{MIN} to T_{MAX}, unless otherwise noted. See Figure 3 and Figure 4 for load conditions.

Table 4.

| Parameter	Symbol	Min	Typ	Max	Unit
Conversion Time: CNV Rising Edge to Data Available	t_{CONV}	0.5		3.7	µs
Acquisition Time	t_{ACQ}	1.8			µs
Time Between Conversions	t_{CYC}	5.5			µs
CNV Pulse Width ($\overline{CS}$ Mode)	t_{CNVH}	10			ns
SCK Period ($\overline{CS}$ Mode)	t_{SCK}	25			ns
SCK Period (Chain Mode)	t_{SCK}				
VIO Above 3 V		29			ns
VIO Above 2.7 V		35			ns
VIO Above 2.3 V		40			ns
SCK Low Time	t_{SCKL}	12			ns
SCK High Time	t_{SCKH}	12			ns
SCK Falling Edge to Data Remains Valid	t_{HSDO}	5			ns
SCK Falling Edge to Data Valid Delay	t_{DSDO}				
VIO Above 3 V				24	ns
VIO Above 2.7 V				30	ns
VIO Above 2.3 V				35	ns
CNV or SDI Low to SDO D17 MSB Valid ($\overline{CS}$ Mode)	t_{EN}				
VIO Above 2.7 V				18	ns
VIO Above 2.3 V				22	ns
CNV or SDI High or Last SCK Falling Edge to SDO High Impedance ($\overline{CS}$ Mode)	t_{DIS}			25	ns
SDI Valid Setup Time from CNV Rising Edge ($\overline{CS}$ Mode)	$t_{SSDICNV}$	30			ns
SDI Valid Hold Time from CNV Rising Edge ($\overline{CS}$ Mode)	$t_{HSDICNV}$	0			ns
SCK Valid Setup Time from CNV Rising Edge (Chain Mode)	$t_{SSCKCNV}$	5			ns
SCK Valid Hold Time from CNV Rising Edge (Chain Mode)	$t_{HSCKCNV}$	8			ns
SDI Valid Setup Time from SCK Falling Edge (Chain Mode)	$t_{SSDISCK}$	8			ns
SDI Valid Hold Time from SCK Falling Edge (Chain Mode)	$t_{HSDISCK}$	10			ns
SDI High to SDO High (Chain Mode with Busy Indicator)	$t_{DSDOSDI}$			36	ns

Timing Diagrams
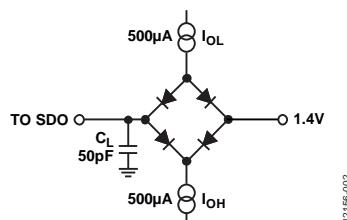
Figure 3. Load Circuit for Digital Interface Timing

[1]2V IF VIO ABOVE 2.5V, VIO − 0.5V IF VIO BELOW 2.5V.
[2]0.8V IF VIO ABOVE 2.5V, 0.5V IF VIO BELOW 2.5V.
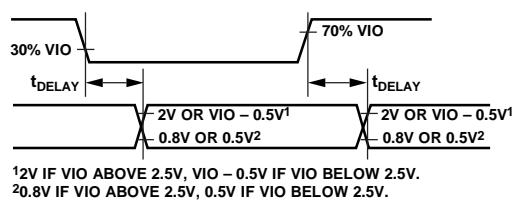
Figure 4. Voltage Levels for Timing

ABSOLUTE MAXIMUM RATINGS

Table 5.

Parameter	Rating
Analog Inputs (IN+, IN−)[1]	GND − 0.3 V to VDD + 0.3 V or ±130 mA
REF	GND − 0.3 V to VDD + 0.3 V
Supply Voltages	
VDD, VIO to GND	−0.3 V to +7 V
VDD to VIO	±7 V
Digital Inputs to GND	−0.3 V to VIO + 0.3 V
Digital Outputs to GND	−0.3 V to VIO + 0.3 V
Storage Temperature Range	−65°C to +150°C
Junction Temperature	150°C
Lead Temperature Range	JEDEC J-STD-20

[1] See the Analog Inputs section of the AD7691 data sheet.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

THERMAL RESISTANCE

θ_{JA} is specified for the worst-case conditions, that is, a device soldered in a circuit board for surface-mount packages.

Table 6. Thermal Resistance

Package Type	θ_{JA}	θ_{JC}	Unit
10-Lead MSOP	200	44	°C/W

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS


```
REF   1  •           10  VIO
VDD   2   AD7691-EP   9  SDI
IN+   3   TOP VIEW    8  SCK
IN−   4  (Not to Scale) 7  SDO
GND   5               6  CNV
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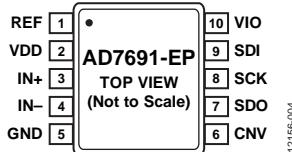
Figure 5. 10-Lead MSOP Pin Configuration

Table 7. Pin Function Descriptions

Pin No.	Mnemonic	Type[1]	Description
1	REF	AI	Reference Input Voltage. The REF range is from 0.5 V to VDD. It is referred to the GND pin. Decouple this pin closely with a 10 µF capacitor.
2	VDD	P	Power Supply.
3	IN+	AI	Differential Positive Analog Input. Referenced to IN−. The input range for IN+ is between 0 V and V_{REF}, centered about $V_{REF}/2$ and must be driven 180° out of phase with IN−.
4	IN−	AI	Differential Negative Analog Input. Referenced to IN+. The input range for IN− is between 0 V and V_{REF}, centered about $V_{REF}/2$ and must be driven 180° out of phase with IN+.
5	GND	P	Power Supply Ground.
6	CNV	DI	Convert Input. This input has multiple functions. On its leading edge, it initiates the conversions and selects the interface mode of the device, either chain mode or $\overline{CS}$ mode. In $\overline{CS}$ mode, it enables the SDO pin when low. In chain mode, the data should be read when CNV is high.
7	SDO	DO	Serial Data Output. The conversion result is output on this pin. It is synchronized to SCK.
8	SCK	DI	Serial Data Clock Input. When the device is selected, the conversion result is shifted out by this clock.
9	SDI	DI	Serial Data Input. This input provides multiple features. It selects the interface mode of the ADC as follows: Chain mode is selected if SDI is low during the CNV rising edge. In this mode, SDI is used as a data input to daisy-chain the conversion results of two or more ADCs onto a single SDO line. The digital data level on SDI is output on SDO with a delay of 18 SCK cycles. $\overline{CS}$ mode is selected if SDI is high during the CNV rising edge. In this mode, either SDI or CNV can enable the serial output signals when low, and if SDI or CNV is low when the conversion is complete, the busy indicator feature is enabled.
10	VIO	P	Input/Output Interface Digital Power. Nominally at the same supply as the host interface (1.8 V, 2.5 V, 3 V, or 5 V).

[1]AI = analog input, DI = digital input, DO = digital output, and P = power.

TYPICAL PERFORMANCE CHARACTERISTICS
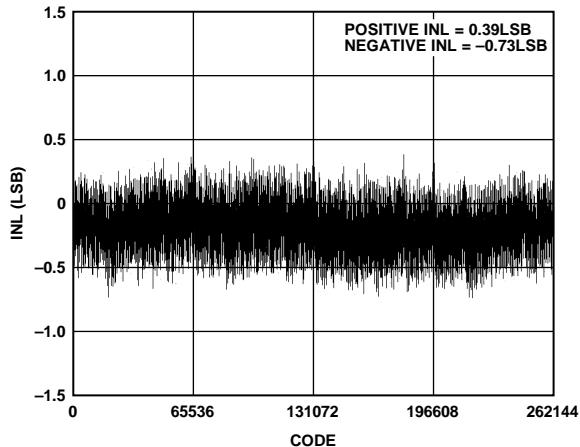
Figure 6. Integral Nonlinearity (INL) vs. Code 2.5 V
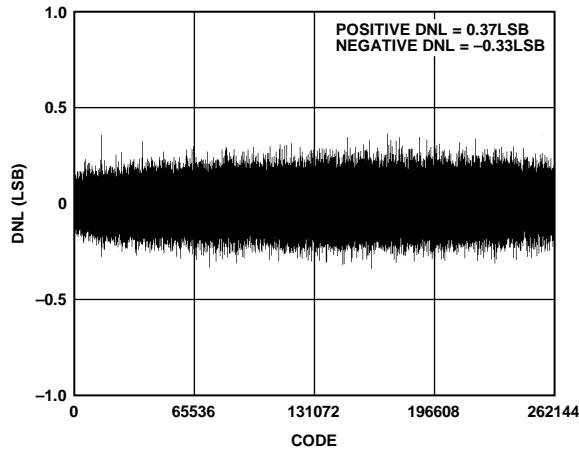
Figure 9. Differential Nonlinearity (DNL) vs. Code, 5 V
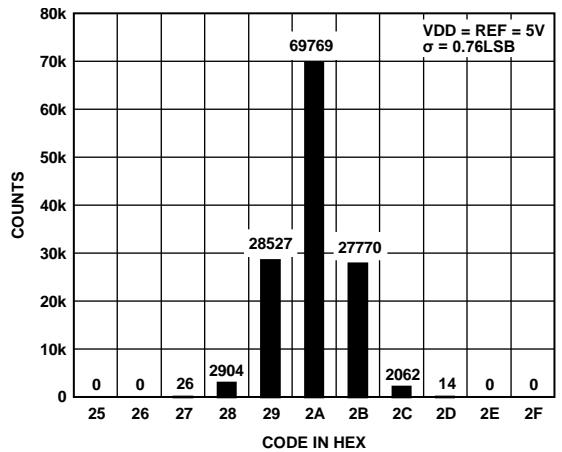

Figure 7. Histogram of a DC Input at the Code Center, 5 V
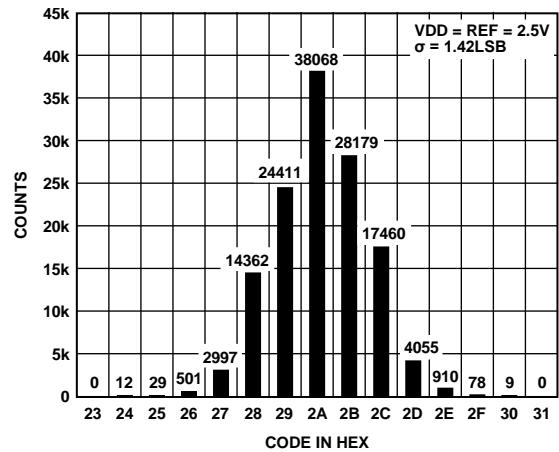

Figure 10. Histogram of a DC Input at the Code Center, 2.5 V
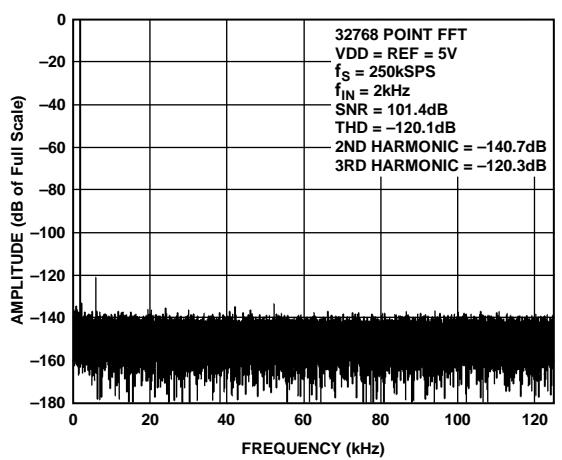

Figure 8. 2 kHz FFT Plot, 5 V
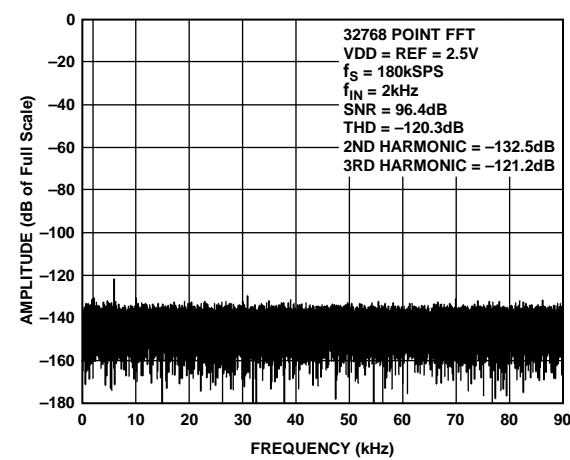
Figure 11. 2 kHz FFT Plot, 2.5 V
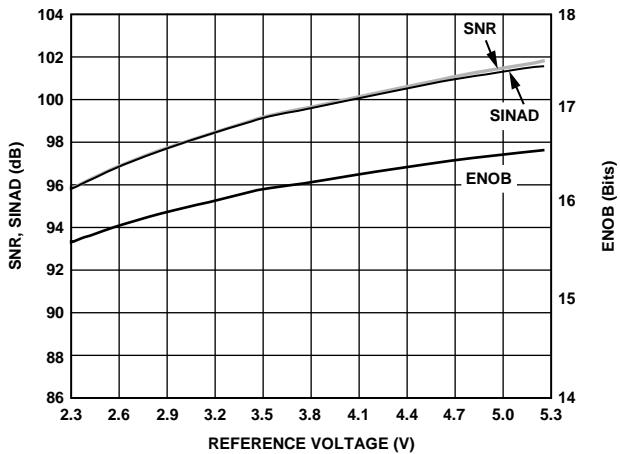
Figure 12. SNR, SINAD, and ENOB vs. Reference Voltage
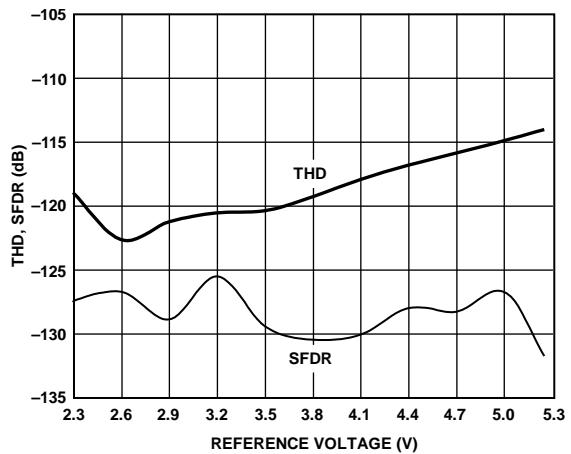

Figure 15. THD, SFDR vs. Reference Voltage
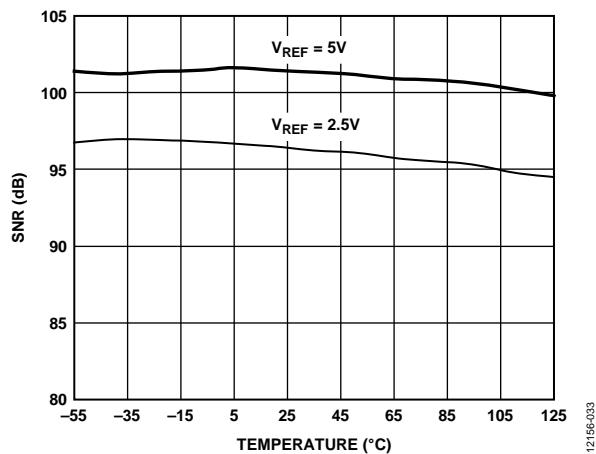
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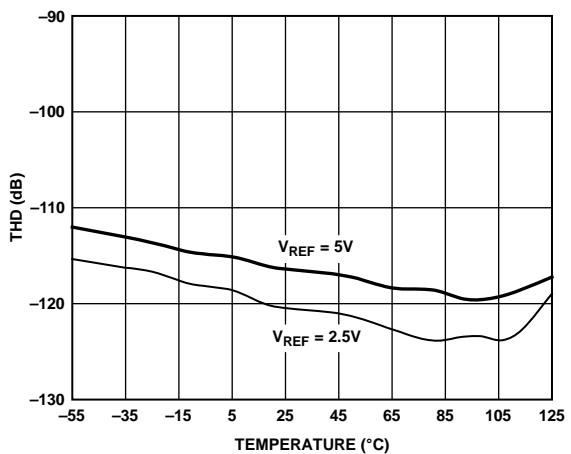
Figure 16. THD vs. Temperature
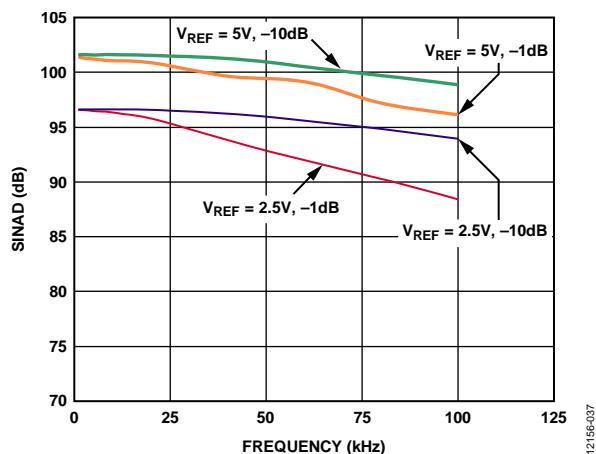
Figure 14. SINAD vs. Frequency
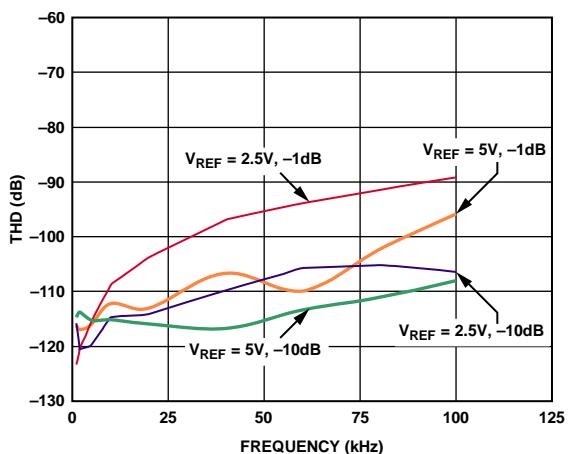
Figure 17. THD vs. Frequency

Figure 18. SNR, THD vs. Input Level

Figure 21. Zero Error, Gain Error vs. Temperature

Figure 19. Operating Current vs. Temperature

Figure 22. Power-Down Current vs. Temperature


Figure 20. Operating Current vs. Supply

Figure 23. t_{DSDO} Delay vs. SDO Capacitance Load and Supply
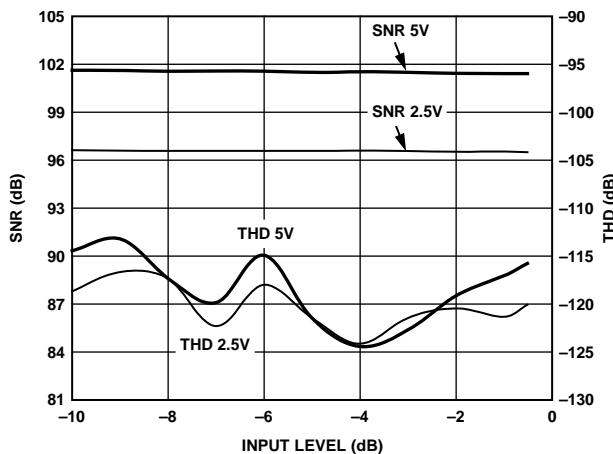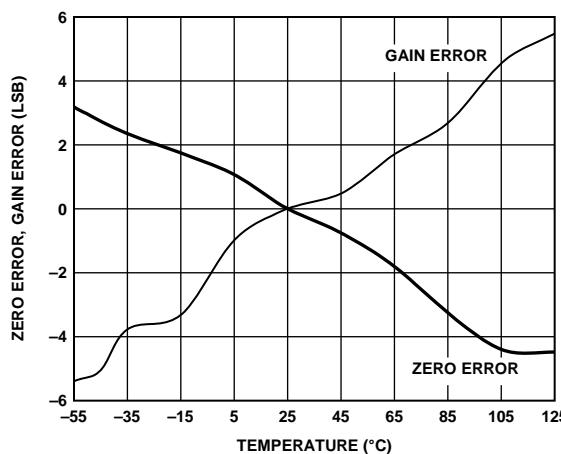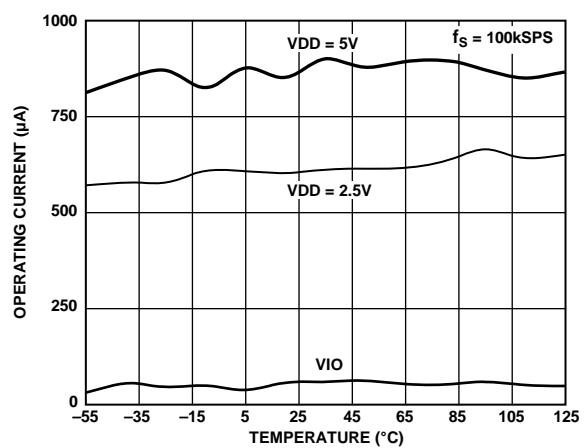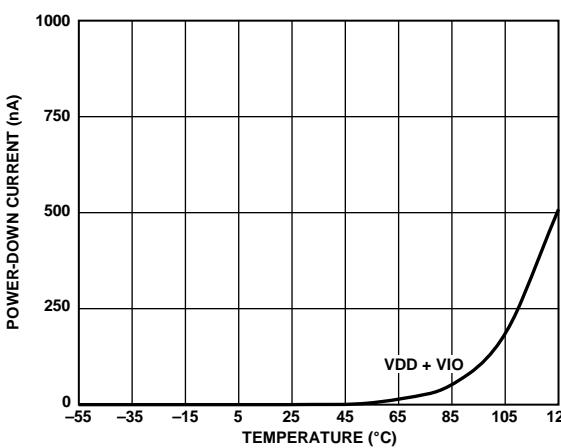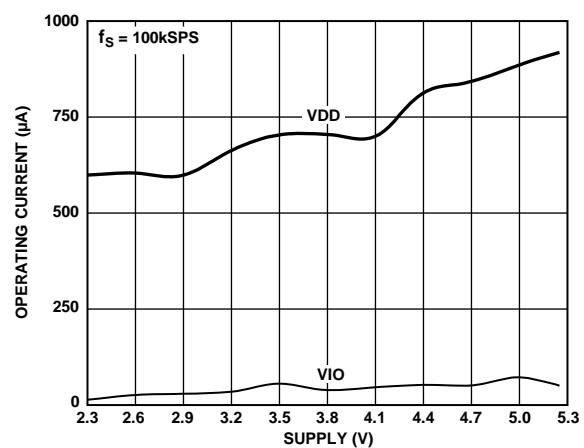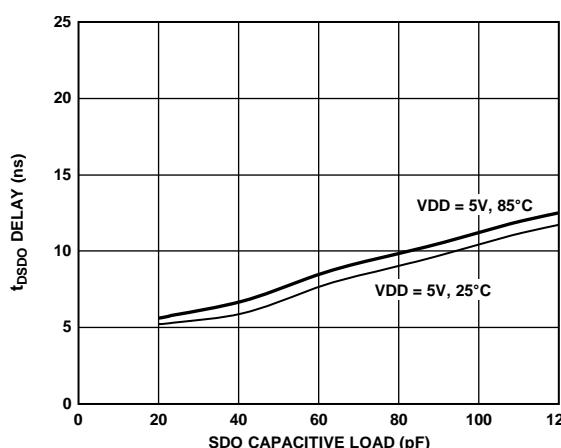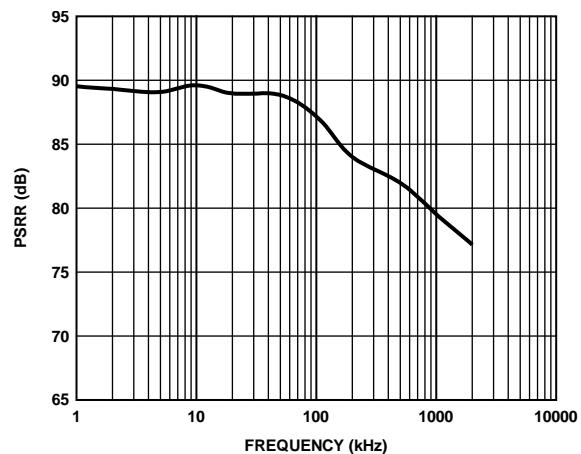
Figure 24. PSSR vs. Frequency
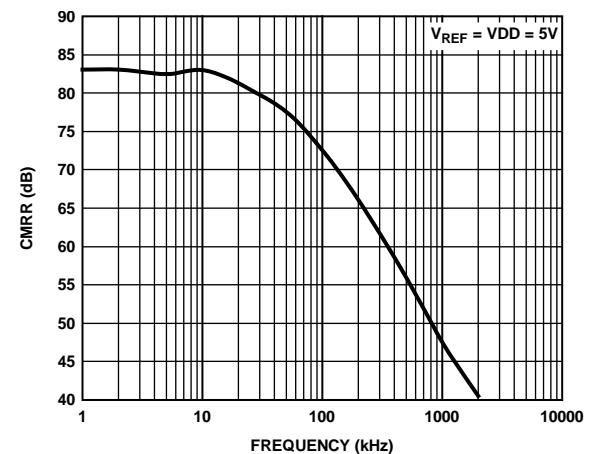
Figure 25. Analog Input CMRR vs. Frequency

OUTLINE DIMENSIONS
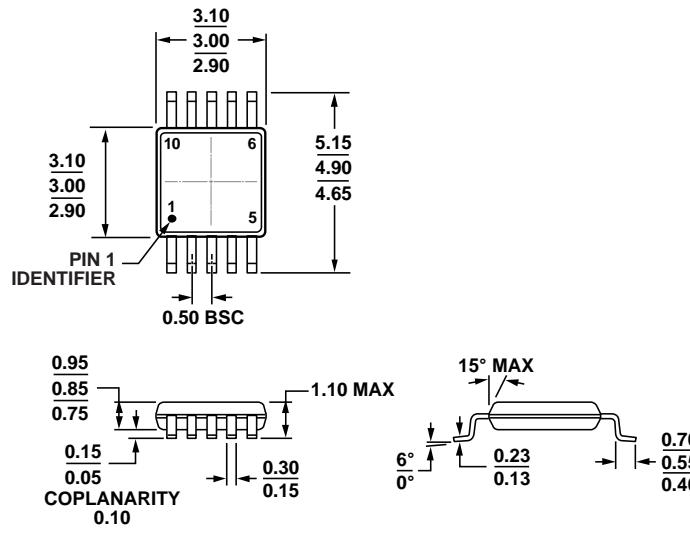
COMPLIANT TO JEDEC STANDARDS MO-187-BA

Figure 26. 10-Lead Mini Small Outline Package [MSOP]
(RM-10)
Dimensions shown in millimeters

ORDERING GUIDE

Model[1]	Temperature Range	Package Description	Package Option	Branding	Ordering Quantity
AD7691SRMZ-EP-RL7	−55°C to +105°C	10-Lead MSOP, Reel	RM-10	C82	1,000
EVAL-AD7691SDZ		Evaluation Board			
EVAL-SDP-CB1Z		Controller Board			

[1] Z = RoHS Compliant Part.

ANALOG DEVICES

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